## Notice of References Cited Application/Control No. 10/787,366 Examiner ANNA DENG Applicant(s)/Patent Under Reexamination EATOUGH ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

		Document Number	Date		
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
*	Α	US-2003/0018759 A1	01-2003	Baumann, Warren John	709/221
*	В	US-2003/0202690 A1	10-2003	Jones et al.	382/139
*	O	US-2005/0125513 A1	06-2005	Sin-Ling Lam et al.	709/220
*	ם	US-5,764,593 A	06-1998	Turpin et al.	713/2
	ш	US-			
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.